# •

## Notic of References Cit d

Application/Control 09/424,966

Applicant(s)/Patent Under Reexamination SHIBATA ET AL.

Examiner
Steven Loke

Art Unit 2811

Page 1 of 1

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name \	·Classification
	Α	US-5786617	07-1998	Merrill et al	257/ 371
	В	US-3865654	02-1975	Chang et al.	257/371
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	7-78885	03-1995	Japan	Iwamatsu	257/371
	0				/	
	Φ					
	ď					
	R					
	S			·		
	T					

### NON-PATENT DOCUMENTS

_	NOIST ATENT BOOOMENTO						
	*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
		٦					
		>					
		>					
		х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.